Docket No.: 60188-448

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of

Customer Number: 20277

Keiichí Fujimoto et al.

Confirmation Number: 2785

Serial No.: 09/964,480

Group Art Unit: 2829

Filed: September 28, 2001

Examiner: Paresh Patel

For:

METHOD

SEMICONDUCTOR INTEGRATED CIRCUIT TESTING SYSTEM AND

AMENDMENT

Mail Stop Fee Amendment Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

In response to the Office Action dated April 10, 2003, having a three-month shortened statutory period for response set to expire on July 10, 2003, and the petition for a three-month extension of time up to and including October 10, 2003 being filed concurrently herewith, reconsideration of the above-identified application is respectfully requested in view of the following amendment and remarks.

10/31